

256K x 4 SRAM

SRAM MEMORY ARRAY

AVAILABLE AS MILITARY SPECIFICATIONS

•MIL-STD-883

FEATURES

- High Speed: 20, 25, 35, and 45
- Battery Backup: 2V data retention
- Low power standby
- High-performance, low-power CMOS double-metal process
- Single +5V ($\pm 10\%$) Power Supply
- Easy memory expansion with CE\ and OE\ options.
- All inputs and outputs are TTL compatible

OPTIONS

- **Timing**
 - 20ns access
 - 25ns access
 - 35ns access
 - 45ns access
 - 55ns access
 - 70ns access

MARKING

-20
-25
-35
-45
-55*
-70*

- **Package(s)**

Ceramic DIP (400 mil)	C	No. 109
Ceramic Quad LCC (contact factory)	ECW	No. 206
Ceramic LCC	EC	No. 207
Ceramic Flatpack	F	No. 303
Ceramic SOJ	DCJ	No. 501

- **Operating Temperature Ranges**

Industrial (-40°C to +85°C)	IT
Military (-55°C to +125°C)	XT

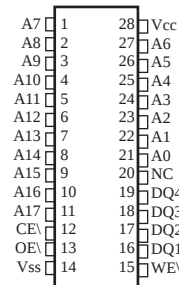
- 2V data retention/low power L

*Electrical characteristics identical to those provided for the 45ns access devices.

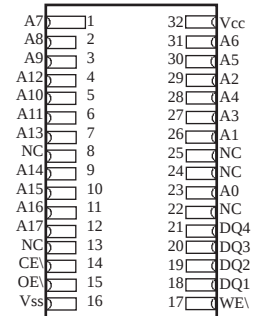
**For more products and information
please visit our web site at
www.micross.com**

PIN ASSIGNMENT (Top View)

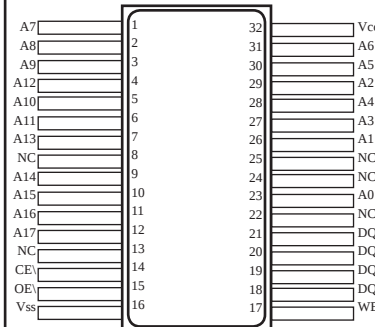
28-Pin DIP (C)
(400 MIL)



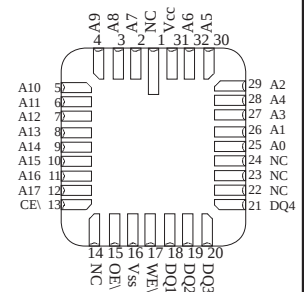
32-Pin LCC (EC)
32-Pin SOJ (DCJ)



32-Pin Flat Pack (F)



32-Pin LCC (ECW)



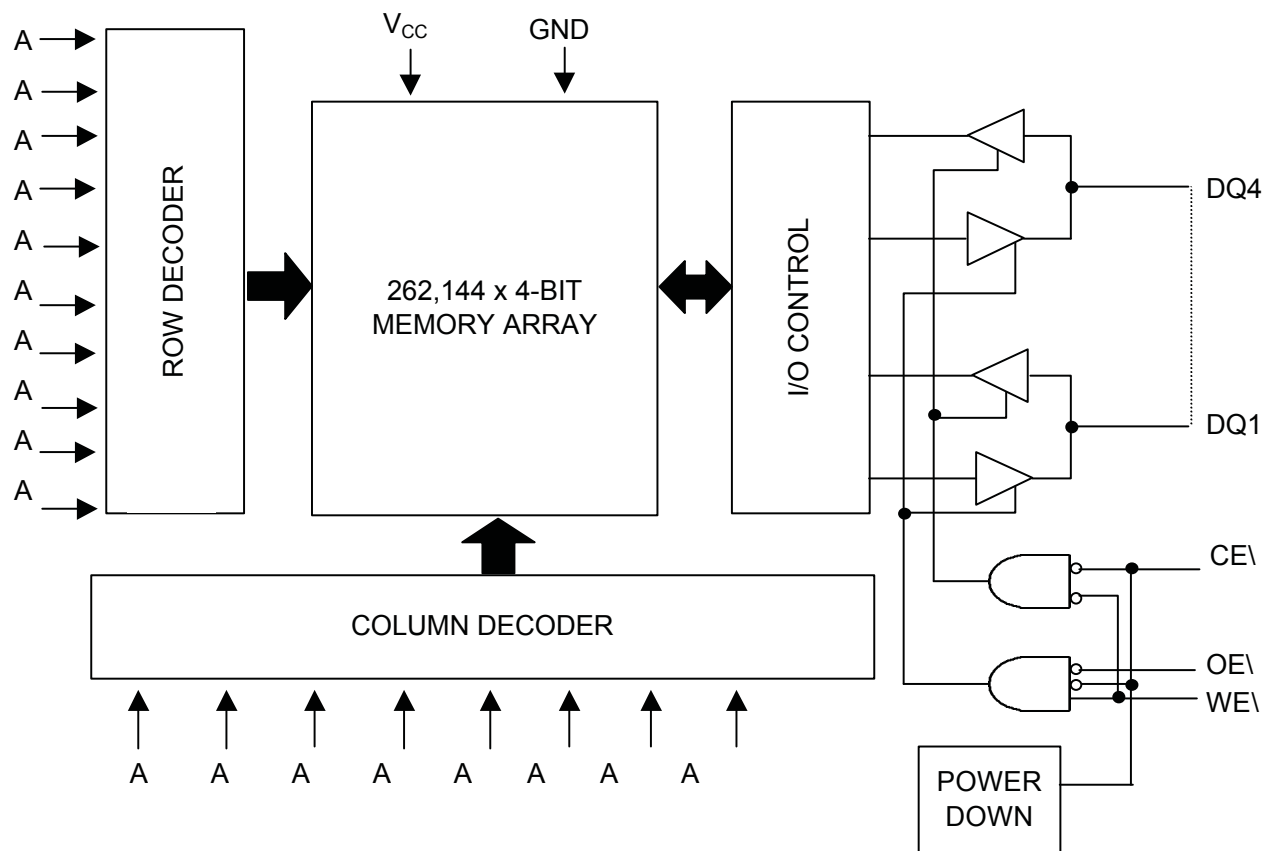
GENERAL DESCRIPTION

The Micross Components SRAM family employs high-speed, low power CMOS designs fabricated using double-layer metal, double-layer polysilicon technology.

For flexibility in high-speed memory applications, Micross offers chip enable (CE\ and output enable (OE\ capability. These enhancements can place the outputs in High-Z for additional flexibility in system design. Writing to these devices is accomplished when write enable (WE\ and CE\ inputs are both LOW. Reading is accomplished when WE\ remains HIGH while CE\ and OE\ go LOW. The devices offer a reduced power standby mode when disabled. This allows system designs to achieve low standby power requirements.

All devices operation from a single +5V power supply and all inputs and outputs are fully TTL compatible.

FUNCTIONAL BLOCK DIAGRAM



TRUTH TABLE

MODE	OE\	CE\	WE\	DQ	POWER
STANDBY	X	H	X	HIGH-Z	STANDBY
READ	L	L	H	Q	ACTIVE
READ	H	L	H	HIGH-Z	ACTIVE
WRITE	X	L	L	D	ACTIVE

ABSOLUTE MAXIMUM RATINGS*

Supply Voltage Range (V_{CC}).....-5V to +7.0V
 Storage Temperature.....-65°C to +150°C
 Voltage on any Pin Relative to V_{SS}.....-5V to V_{CC}+5V
 Max Junction Temperature.....+175°C
 Lead Temperature (soldering 10 seconds).....+260°C
 Power Dissipation1 W

*Stresses greater than those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

ELECTRICAL CHARACTERISTICS AND RECOMMENDED DC OPERATING CONDITIONS

(-55°C ≤ T_C ≤ 125°C; V_{CC} = 5V ±10%)

DESCRIPTION	CONDITIONS	SYM	MIN	MAX	UNITS	NOTES
Input High (Logic 1) Voltage		V _{IH}	2.2	V _{CC} +0.5	V	1
Input Low (Logic 0) Voltage		V _{IL}	-0.5	0.8	V	1
Input Leakage Current	0V ≤ V _{IN} ≤ V _{CC}	I _{LI}	-10	10	μA	
Output Leakage Current	Output(s) disabled 0V ≤ V _{OUT} ≤ V _{CC}	I _{LO}	-10	10	μA	
Output High Voltage	I _{OH} = -4.0mA	V _{OH}	2.4		V	1
Output Low Voltage	I _{OL} = 8.0mA	V _{OL}		0.4	V	1

PARAMETER	CONDITIONS	SYM	MAX				UNITS	NOTES
			-20	-25	-35	-45		
Power Supply Current: Operating	WE\, CE\ ≤ V _{IL} ; V _{CC} = MAX Output Open	I _{CC}	180	180	180	180	mA	3
Power Supply Current: Standby	CE\ ≥ V _{IH} ; All Other Inputs ≤ V _{IL} or ≥ V _{IH} , V _{CC} = MAX	I _{SBT2}	25	25	25	25	mA	
	CE\ ≥ V _{CC} - 0.2V; V _{CC} = MAX V _{IL} ≤ V _{SS} + 0.2V V _{IH} ≥ V _{CC} - 0.2V; f = 0 Hz*	I _{SBC}	16	16	16	16	mA	

* “L” version only.

CAPACITANCE

PARAMETER	CONDITIONS	SYM	MAX	UNITS	NOTES
Input Capacitance	V _{IN} = 0V, T _A = 25°C, f = 1MHz	C _I	12	pF	4
Output Capacitance (DQ1-DQ4)	V _{CC} = 5V	C _O	14	pF	4

ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS

(Note 5) ($-55^{\circ}\text{C} \leq T_c \leq 125^{\circ}\text{C}$; $V_{cc} = 5V \pm 10\%$)

DESCRIPTION	SYMBOL	-20		-25		-35		-45		UNITS	NOTES
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
READ CYCLE											
READ cycle time	t _{RC}	20		25		35		45		ns	
Address access time	t _{AA}		20		25		35		45	ns	
Chip Enable access time	t _{ACE}		20		25		35		45	ns	
Output hold from address change	t _{OH}	3		3		3		3		ns	
Chip Enable to output in Low-Z	t _{LZCE}	3		3		3		3		ns	4, 6, 7
Chip disable to output in High-Z	t _{HZCE}		10		12		20		25	ns	4, 6, 7
Chip Enable to power-up time	t _{PU}	0		0		0		0		ns	4
Chip disable to power-down time	t _{PD}		20		25		35		45	ns	4
Output Enable access time	t _{AOE}		8		10		20		25	ns	
Output Enable to output in Low-Z	t _{LZOE}	0		0		0		0		ns	4, 6, 7
Output disable to output in High-Z	t _{HZOE}		8		10		20		25	ns	4, 6, 7
WRITE CYCLE											
WRITE cycle time	t _{WC}	20		25		35		45		ns	
Chip Enable to end of write	t _{CW}	15		20		30		35		ns	
Address valid to end of write	t _{AW}	15		20		30		35		ns	
Address setup time	t _{AS}	0		0		0		0		ns	
Address hold from end of write	t _{AH}	0		0		0		0		ns	
WRITE pulse width	t _{WP}	15		20		30		35		ns	
Data setup time	t _{DS}	12		15		20		25		ns	
Data hold time	t _{DH}	0		0		0		0		ns	
Write disable to output in Low-Z	t _{LZWE}	3		3		3		3		ns	4, 6, 7
Write Enable to output in High-Z	t _{HZWE}	0	8	0	10	0	15	0	20	ns	4, 6, 7

AC TEST CONDITIONS

Input pulse levels	V _{SS} to 3.0V
Input rise and fall times	5ns
Input timing reference levels	1.5V
Output reference levels	1.5V
Output load	See Figures 1 and 2

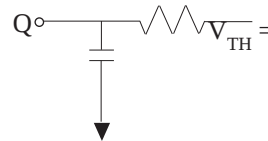


Fig. 1 Output Load Equivalent

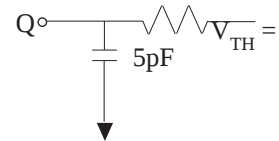


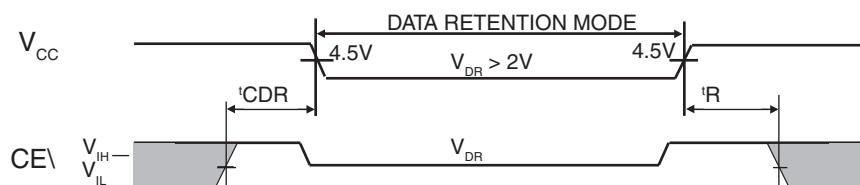
Fig. 2 Output Load Equivalent

NOTES

- All voltages referenced to V_{SS} (GND).
- 3V for pulse width < 20ns
- I_{CC} is dependent on output loading and cycle rates.
The specified value applies with the outputs unloaded, and $f = \frac{1}{RC (MIN)}$ Hz.
- This parameter is guaranteed but not tested.
- Test conditions as specified with the output loading as shown in Fig. 1 unless otherwise noted.
- Minimum of 5pF for t_{EHQZ}, t_{OHQZ}, t_{ELQX}, t_{OLQX}, and t_{WHQX}.
- At any given temperature and voltage condition,
- 'HZCE is less than 'LZCE, and 'HZWE is less than 'LZWE and 'HZOE is less than 'LZOE.
- WE\ is HIGH for READ cycle.
- Device is continuously selected. Chip enables and output enables are held in their active state.
- Address valid prior to, or coincident with, latest occurring chip enable.
- 'RC = Read Cycle Time.
- Chip enable (CE\) and write enable (WE\) can initiate and terminate a WRITE cycle.

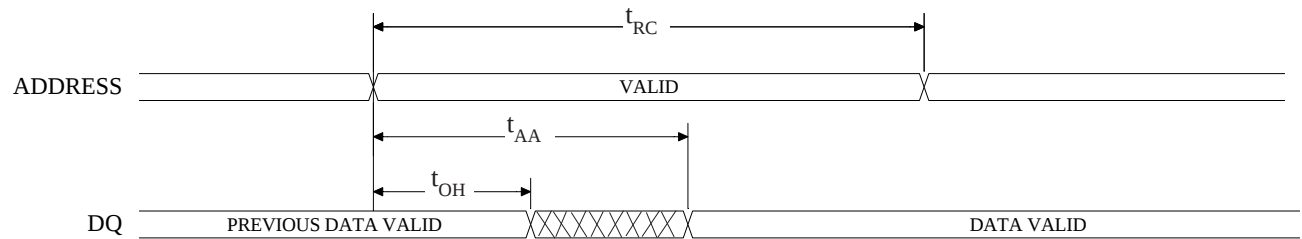
DATA RETENTION ELECTRICAL CHARACTERISTICS (L Version Only)

DESCRIPTION	CONDITIONS	SYM	MIN	MAX	UNITS	NOTES
V _{CC} for Retention Data		V _{DR}	2		V	
Data Retention Current	CE\ ≥ (V _{CC} -0.2V) and V _{IN} ≥ (V _{CC} -0.2V) or ≤ 0.2V V _{CC} = 2V	I _{CCDR}		5	mA	
Chip Deselect to Data Retention Time		t _{CDR}	0	--	ns	4
Operation Recovery Time		t _R	t _{RC}		ns	4, 11

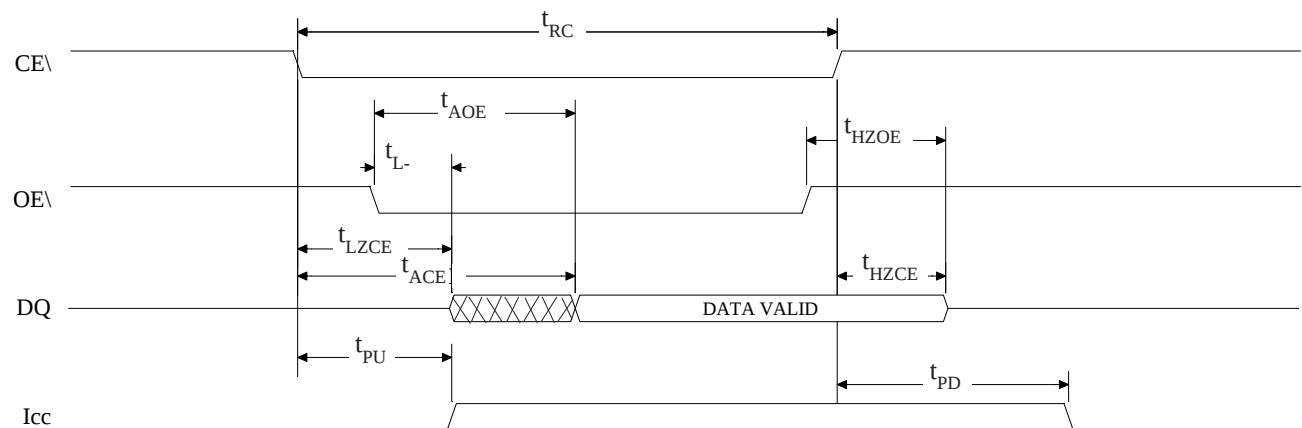
LOW V_{CC} DATA RETENTION WAVEFORM


■ DON'T CARE
■ UNDEFINED

READ CYCLE NO. 1 ^{8,9}

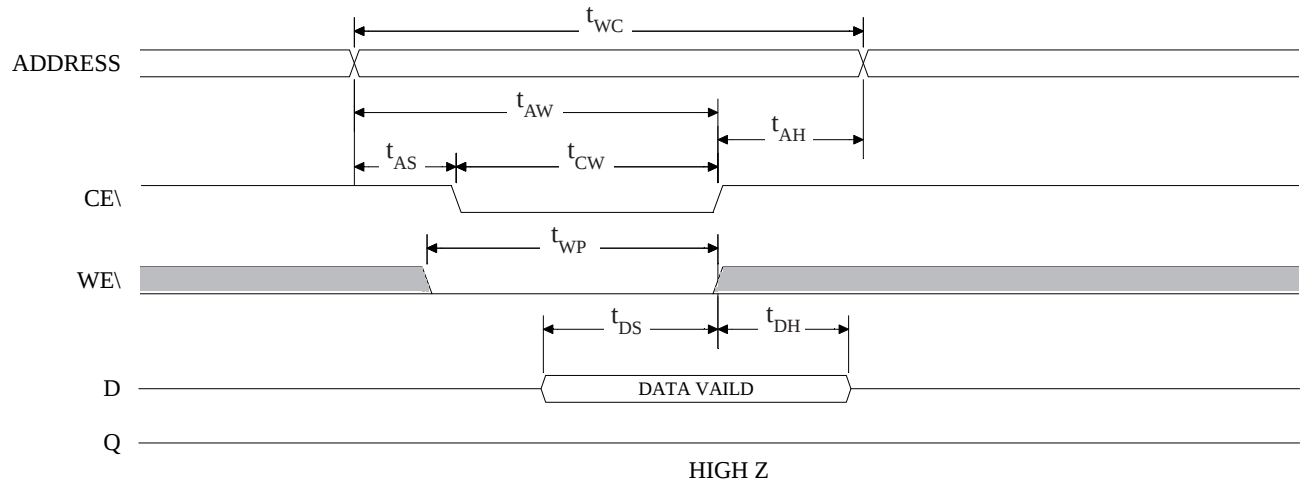


READ CYCLE NO. 2 ^{7,8,10}

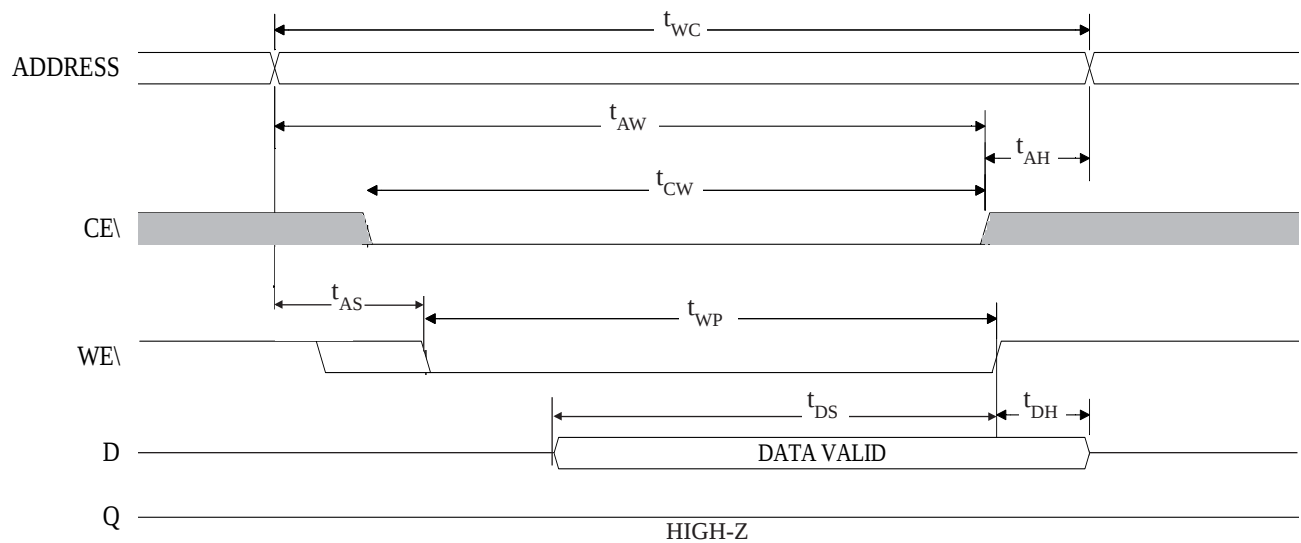


■ DON'T CARE
■ UNDEFINED

WRITE CYCLE NO. 1 ¹²
(Chip Enabled Controlled)



WRITE CYCLE NO. 2 ^{7, 12}
(Write Enabled Controlled)

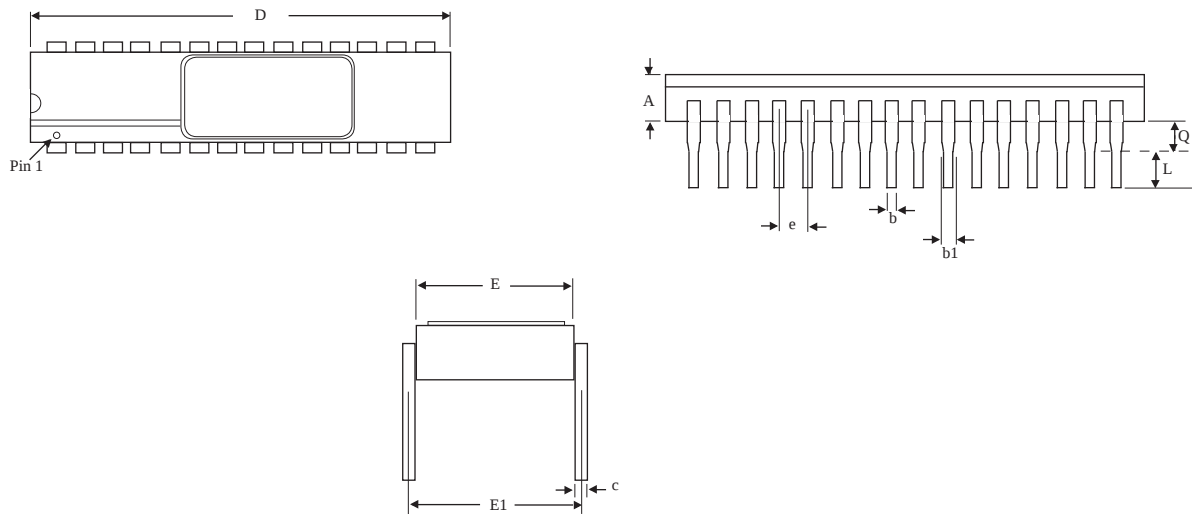


NOTE: Output enable (OE\) is inactive (HIGH).

 DON'T CARE
 UNDEFINED

MECHANICAL DEFINITIONS*

Micross Case #109 (Package Designator C)

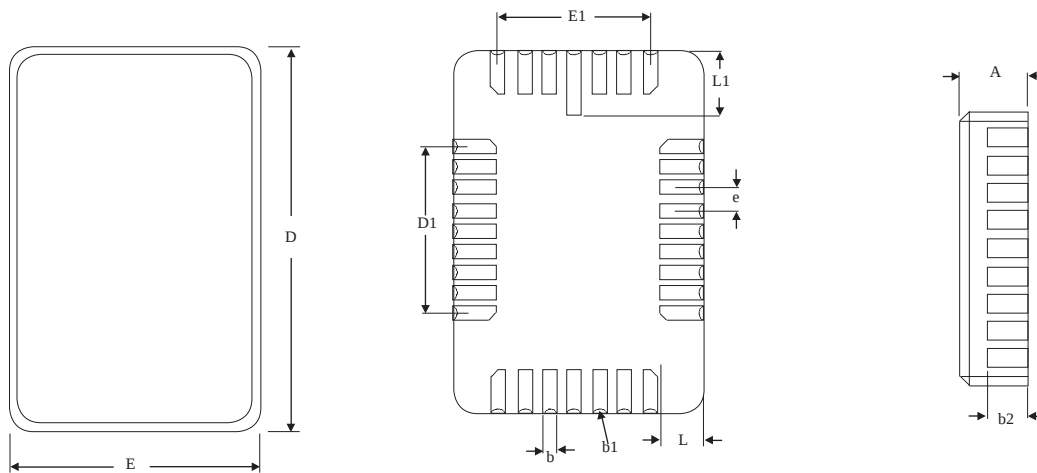


SYMBOL	PACKAGE SPECIFICATIONS	
	MIN	MAX
A	0.090	0.110
b	0.016	0.020
b1	0.040	0.060
c	0.008	0.012
D	1.386	1.414
E	0.385	0.405
E1	0.390	0.410
e	0.090	0.110
L	0.125	0.175
Q	0.040	0.060

*All measurements are in inches.

MECHANICAL DEFINITIONS*

Micross Case #206 (Package Designator ECW)

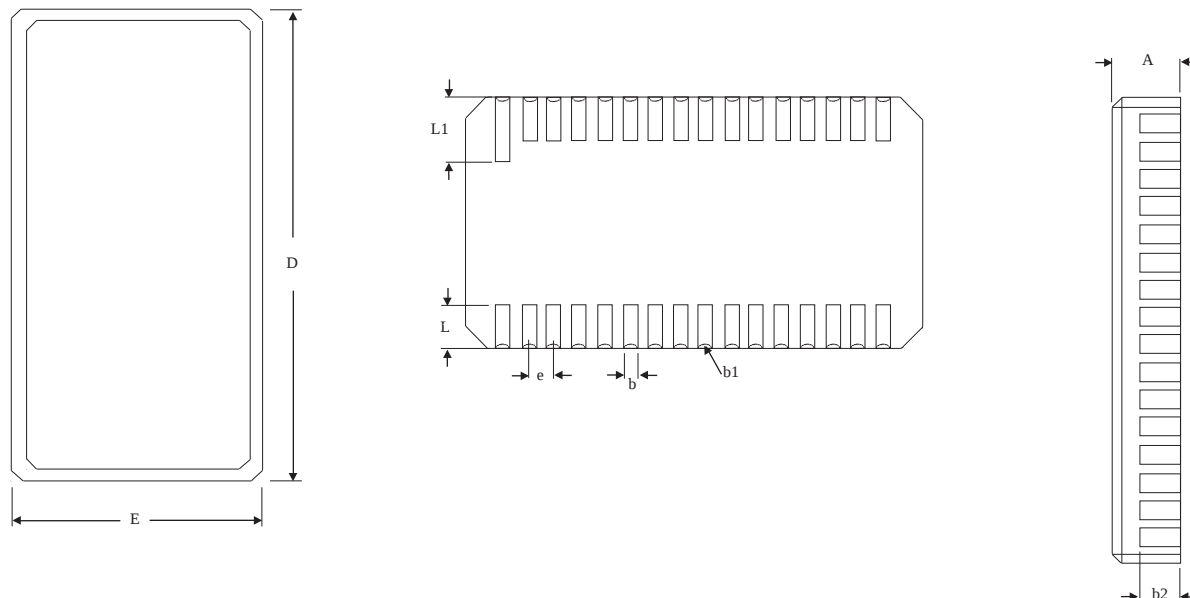


SYMBOL	PACKAGE SPECIFICATIONS	
	MIN	MAX
A	0.077	0.093
b	0.022	0.028
b1	0.004	0.014
b2	0.054	0.066
D	0.742	0.758
D1	0.395	0.405
E	0.442	0.458
E1	0.295	0.305
e	0.045	0.055
L	0.045	0.055
L1	0.077	0.093

*All measurements are in inches.

MECHANICAL DEFINITIONS*

Microcross Case #207 (Package Designator EC)

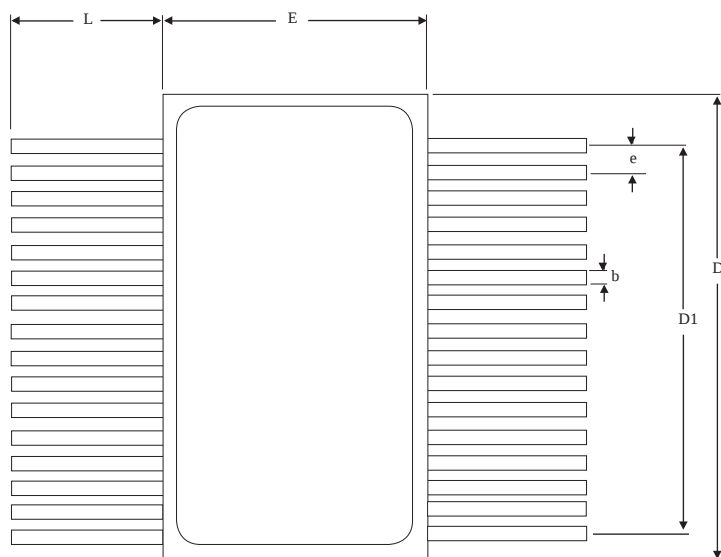


SYMBOL	PACKAGE SPECIFICATIONS	
	MIN	MAX
A	0.080	0.100
b	0.022	0.028
b1	0.004	0.014
b2	0.054	0.066
D	0.815	0.835
E	0.392	0.408
e	0.045	0.055
L	0.070	0.080
L1	0.090	0.110

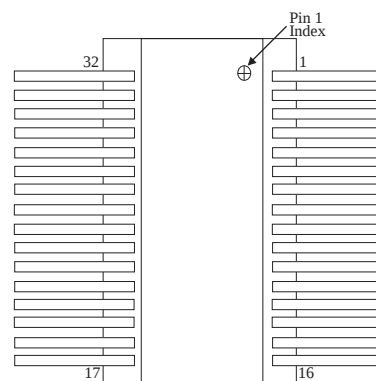
*All measurements are in inches.

MECHANICAL DEFINITIONS*

Micross Case #303 (Package Designator F)



Top View



Bottom View

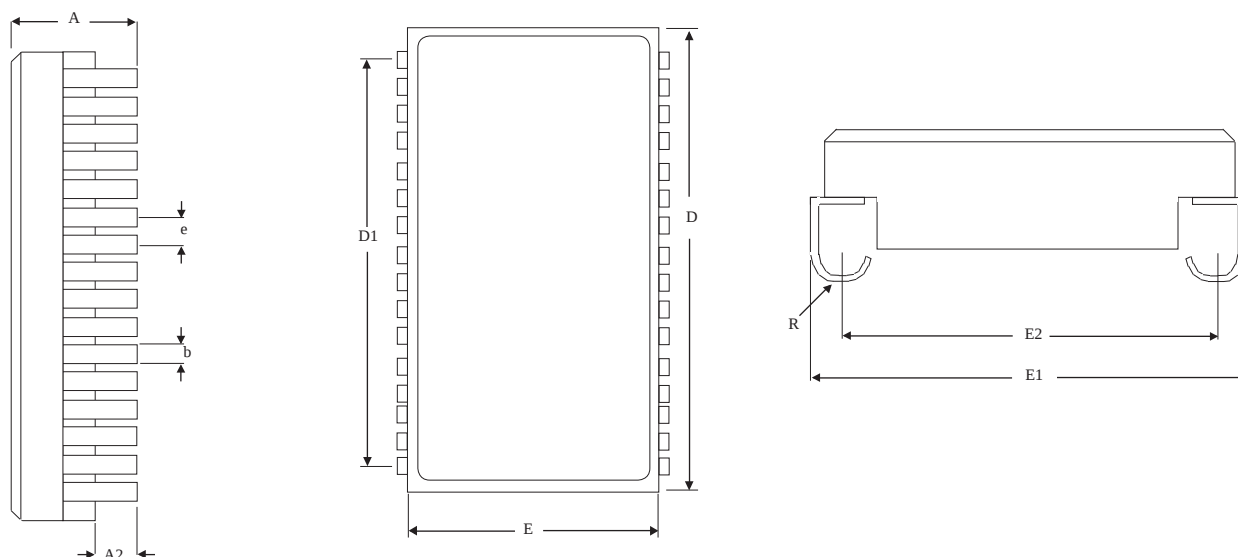


SYMBOL	PACKAGE SPECIFICATIONS	
	MIN	MAX
A	--	0.125
b	0.015	0.019
c	0.004	0.006
D	0.812	0.828
D1	0.745	0.755
E	0.405	0.415
E2	0.324	0.336
e	0.045	0.055
L	0.290	0.310
Q	0.027	0.033

*All measurements are in inches.

MECHANICAL DEFINITIONS*

Micross Case #501 (Package Designator DCJ)



SYMBOL	PACKAGE SPECIFICATIONS	
	MIN	MAX
A	0.135	0.153
A2	0.026	0.036
b	0.015	0.019
D	0.812	0.828
D1	0.740	0.755
E	0.405	0.415
e	0.045	0.055
E1	0.435	0.445
E2	0.360	0.380
R	0.030	0.040

*All measurements are in inches.

ORDERING INFORMATION

EXAMPLE: MT5C1005C-20L/IT

Device Number	Package Type	Speed ns	Options**	Process
MT5C1005	C	-20	L	/*
MT5C1005	C	-25	L	/*
MT5C1005	C	-35	L	/*
MT5C1005	C	-40	L	/*
MT5C1005	C	-55	L	/*
MT5C1005	C	-70	L	/*

EXAMPLE: MT5C1005EC-45/XT

Device Number	Package Type	Speed ns	Options**	Process
MT5C1005	EC ECW	-20	L	/*
MT5C1005	EC ECW	-25	L	/*
MT5C1005	EC ECW	-35	L	/*
MT5C1005	EC ECW	-40	L	/*
MT5C1005	EC ECW	-55	L	/*
MT5C1005	EC ECW	-70	L	/*

EXAMPLE: MT5C1005F-25L/883C

Device Number	Package Type	Speed ns	Options**	Process
MT5C1005	F	-20	L	/*
MT5C1005	F	-25	L	/*
MT5C1005	F	-35	L	/*
MT5C1005	F	-40	L	/*
MT5C1005	F	-55	L	/*
MT5C1005	F	-70	L	/*

EXAMPLE: MT5C1005DCJ-70/XT

Device Number	Package Type	Speed ns	Options**	Process
MT5C1005	DCJ	-20	L	/*
MT5C1005	DCJ	-25	L	/*
MT5C1005	DCJ	-35	L	/*
MT5C1005	DCJ	-40	L	/*
MT5C1005	DCJ	-55	L	/*
MT5C1005	DCJ	-70	L	/*

***AVAILABLE PROCESSES**

IT = Industrial Temperature Range
 XT = Extended Temperature Range
 883C = Full Military Processing

-40°C to +85°C
 -55°C to +125°C
 -55°C to +125°C

**** OPTIONS**

L = 2V Data Retention/Low Power